## **Radiation Physics and Chemistry**

Volume 75, Issue 11 SPEC. ISS., November 2006, Pages 1869-1871

Influence of the molecular structure on the interface formation between magnesium and organic semiconductors

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## Abstract

The interface formation between three different perylene derivatives and Mg were investigated by high-resolution soft X-ray photoemission spectroscopy using synchrotron radiation at BESSY. The chemical and electronic properties of these interfaces were obtained after fitting the  $C_{1s}$ ,  $O_{1s}$ ,  $N_{1s}$  and  $Mg_{2p}$  core-level emission spectra as a function of Mg thickness. A strong chemical interaction between Mg and the molecular end groups is observed leading to the formation of new chemical components and/or charge redistribution due to the presence of the metal. © 2006 Elsevier Ltd. All rights reserved.

## **Author Keywords**

Interfaces; Metal contacts; Organic semiconductors